



INFORMATION DISCLOSURE  
CITATION IN AN  
APPLICATION

(PTO-1449)

ATTY. DOCKET NO.  
**60188-777**

SERIAL NO.

10781788

**APPLICANT**  
**Takefumi YOSHIKAWA**

FILING DATE

GROUP 2819

U.S. PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS

FOREIGN PATENT DOCUMENT						
EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Code-Number + Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation
						Yes      No
		JP 11-68312	03/03/1999	NEC CORP.		JAPAN (w/English Abstract)
		JP 2000-67577 A	03/03/2000	MITSUBISHI ELECTRIC CORP.		JAPAN (w/English Abstract)
		JP 2002-300143	10/11/2002	MATSUSHITA ELECTRIC CO LTD.		JAPAN (w/English Abstract)

OTHER ART (check one: Author, Title, Date, Recipient, Reasons, Etc.)

EXAMINER: Thi Nguyen

DATE CONSIDERED 03/29/2008

**EXAMINER:** Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. (Use **initials** if reference is not considered.) **Initials** American.

\* Applicant's unique citizen designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language translation is attached.

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH / IN



SHEET 1 OF 1

INFORMATION DISCLOSURE CITATION IN AN APPLICATION				ATTY. DOCKET NO. 60188-777	SERIAL NO. 10781788	
				APPLICANT Takefumi YOSHIKAWA		
				FILING DATE February 20, 2004	GROUP 2810	
U.S. PATENT DOCUMENTS						
EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code(s) if known	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	
/LN/	US	2003/0031133 A1	02/13/2003	Momtaz		
	US					
	US					
	US					
	US					
	US					
	US					
	US					
	US					
	US					
	US					
	US					
	US					
FOREIGN PATENT DOCUMENTS						
EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Code-Number + Kind Code(s) if known	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation
		JP 11-88312	03/30/1998	NEC CORP.		Yes <input type="checkbox"/> No <input type="checkbox"/>
		JP 2000-07577 A	03/03/2000	MITSUBISHI ELECTRIC CORP.		Yes <input type="checkbox"/> No <input type="checkbox"/>
		JP 2002-300143	10/11/2002	MATSUSHITA ELECTRIC CO LTD.		Yes <input type="checkbox"/> No <input type="checkbox"/>
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)						
EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.				
EXAMINER <i>Linh Nguyen</i>		/Linh Nguyen/		DATE CONSIDERED <i>8/22/07</i>		03/29/2008

EXAMINER: Indicate reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered.  
Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /LN/